

**Notice of References Cited**

Application/Control No.

10/534,794

Applicant(s)/Patent Under  
Reexamination  
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Examiner

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Art Unit

1615

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,227,147	07-1993	Yoshimura et al.	423/308
*	B	US-7,507,286	03-2009	Edidin et al.	106/690
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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